

<IGBT Modules>

CM1000DUC-34SA

HIGH POWER SWITCHING USE
INSULATED TYPE



dual switch (Half-Bridge)

Collector current I_C **1 0 0 0 A**
 Collector-emitter voltage V_{CES} **1 7 0 0 V**
 Maximum junction temperature T_{jmax} **1 7 5 °C**

- Flat base Type
- Copper base plate
- RoHS Directive compliant
- Recognized under UL1557, File E323585

APPLICATION

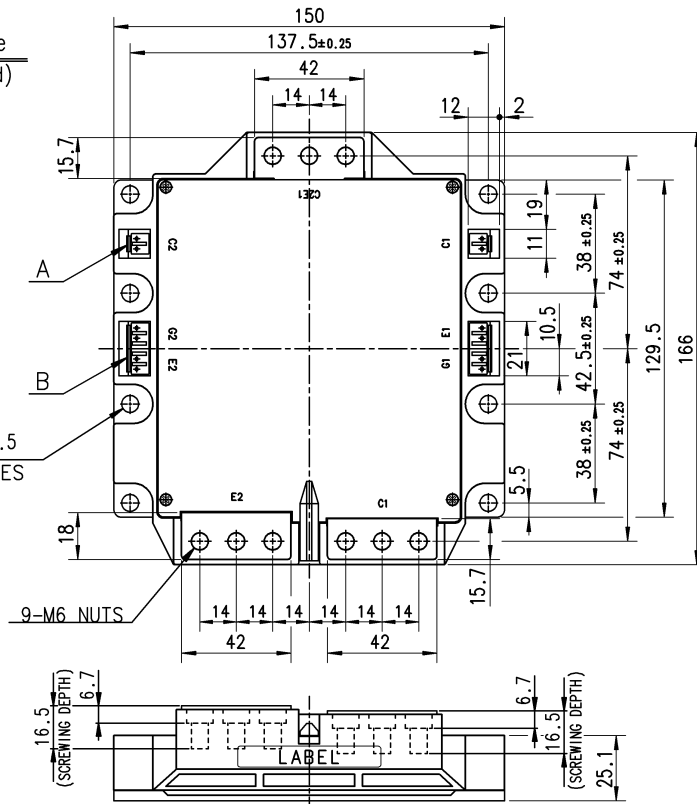
Wind power, Photovoltaic (Solar) power, AC Motor Control, Motion/Servo Control, Power supply, etc.

OUTLINE DRAWING & INTERNAL CONNECTION

A, B HOUSING Type
(J.S.T.Mfg.Co.,Ltd)

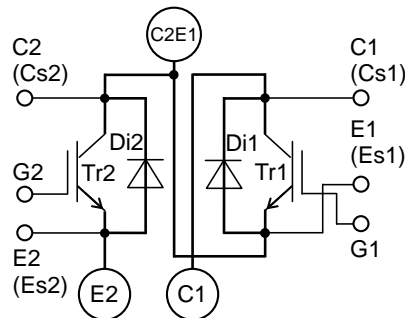
A : VHR-2N
B : VHR-5N

8- $\phi 6.5$
MOUNTING HOLES



Dimension in mm

INTERNAL CONNECTION



Tolerance otherwise specified

| Division of Dimension | Tolerance |
|-----------------------|-----------|
| 0.5 to 3 | ± 0.2 |
| over 3 to 6 | ± 0.3 |
| over 6 to 30 | ± 0.5 |
| over 30 to 120 | ± 0.8 |
| over 120 to 400 | ± 1.2 |

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MAXIMUM RATINGS (T_j=25 °C, unless otherwise specified)

| Symbol | Item | Conditions | Rating | Unit |
|--------------------------|--------------------------------|---|------------|------|
| V _{CES} | Collector-emitter voltage | G-E short-circuited | 1700 | V |
| V _{GES} | Gate-emitter voltage | C-E short-circuited | ± 20 | V |
| I _C | Collector current | DC, T _C =125 °C (Note2, 4) | 1000 | A |
| I _{CRM} | | Pulse, Repetitive (Note3) | 2000 | |
| P _{tot} | Total power dissipation | T _C =25 °C (Note2, 4) | 10000 | W |
| I _E (Note1) | Emitter current | DC (Note2) | 1000 | A |
| I _{ERM} (Note1) | | Pulse, Repetitive (Note3) | 2000 | |
| V _{isol} | Isolation voltage | Terminals to base plate, RMS, f=60 Hz, AC 1 min | 4000 | V |
| T _{jmax} | Maximum junction temperature | Instantaneous event (overload) | 175 | °C |
| T _{cmax} | Maximum case temperature | (Note4) | 125 | |
| T _{jop} | Operating junction temperature | Continuous operation (under switching) | -40 ~ +150 | °C |
| T _{stg} | Storage temperature | - | -40 ~ +125 | |

ELECTRICAL CHARACTERISTICS (T_j=25 °C, unless otherwise specified)

| Symbol | Item | Conditions | Limits | | | Unit | |
|-------------------------|--------------------------------------|---|------------------------|-------|------|------|---|
| | | | Min. | Typ. | Max. | | |
| I _{CES} | Collector-emitter cut-off current | V _{CE} =V _{CES} , G-E short-circuited | - | - | 1.0 | mA | |
| I _{GES} | Gate-emitter leakage current | V _{GE} =V _{GES} , C-E short-circuited | - | - | 10 | μA | |
| V _{GE(th)} | Gate-emitter threshold voltage | I _C =100 mA, V _{CE} =10 V | 5.4 | 6.0 | 6.6 | V | |
| V _{CESat} | Collector-emitter saturation voltage | I _C =1000 A (Note5), V _{GE} =15 V, Terminal=chip | T _j =25 °C | - | 1.9 | 2.4 | V |
| | | | T _j =125 °C | - | 2.1 | - | |
| | | | T _j =150 °C | - | 2.15 | - | |
| C _{ies} | Input capacitance | V _{CE} =10 V, G-E short-circuited | - | - | 260 | nF | |
| C _{oes} | Output capacitance | | - | - | 27 | | |
| C _{res} | Reverse transfer capacitance | | - | - | 5 | | |
| Q _G | Gate charge | V _{CC} =1000 V, I _C =1000 A, V _{GE} =15 V | - | 4700 | - | nC | |
| t _{d(on)} | Turn-on delay time | V _{CC} =1000 V, I _C =1000 A, V _{GE} =±15 V, R _G =2.0 Ω, Inductive load | - | - | 900 | ns | |
| t _r | Rise time | | - | - | 350 | | |
| t _{d(off)} | Turn-off delay time | | - | - | 1250 | | |
| t _f | Fall time | | - | - | 400 | | |
| V _{EC} (Note1) | Emitter-collector voltage | I _E =1000 A (Note5), G-E short-circuited, Terminal=chip | T _j =25 °C | - | 4.0 | 5.2 | V |
| | | | T _j =125 °C | - | 2.8 | - | |
| | | | T _j =150 °C | - | 2.6 | - | |
| t _{rr} (Note1) | Reverse recovery time | V _{CC} =1000 V, I _E =1000 A, V _{GE} =±15 V, | - | - | 400 | ns | |
| Q _{rr} (Note1) | Reverse recovery charge | R _G =2.0 Ω, Inductive load | - | 270 | - | μC | |
| E _{on} | Turn-on switching energy per pulse | V _{CC} =1000 V, I _C =I _E =1000 A, | - | 239 | - | mJ | |
| E _{off} | Turn-off switching energy per pulse | V _{GE} =±15 V, R _G =2.0 Ω, | - | 269 | - | | |
| E _{rr} (Note1) | Reverse recovery energy per pulse | T _j =150 °C, Inductive load | - | 130 | - | mJ | |
| R _{CC'+EE'} | Internal lead resistance | Main terminals-chip, per switch, T _C =25 °C (Note4) | - | 0.286 | - | mΩ | |
| r _g | Internal gate resistance | Per switch | - | 0.56 | - | Ω | |

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THERMAL RESISTANCE CHARACTERISTICS

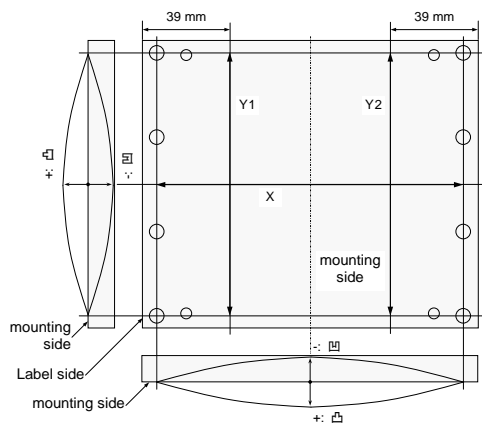
| Symbol | Item | Conditions | Limits | | | Unit |
|----------------|----------------------------|---|--------|------|------|------|
| | | | Min. | Typ. | Max. | |
| $R_{th(j-c)Q}$ | Thermal resistance | Junction to case, per IGBT (Note4) | - | - | 15 | K/kW |
| $R_{th(j-c)D}$ | | Junction to case, per DIODE (Note4) | - | - | 24 | K/kW |
| $R_{th(c-s)}$ | Contact thermal resistance | Case to heat sink, per 1/2 module, Thermal grease applied (Note4, 6) | - | 12 | - | K/kW |

MECHANICAL CHARACTERISTICS

| Symbol | Item | Conditions | Limits | | | Unit |
|--------|------------------------|-------------------------------------|--------|------|------|---------------|
| | | | Min. | Typ. | Max. | |
| M_t | Mounting torque | Main terminals M 6 screw | 3.5 | 4.0 | 4.5 | N·m |
| M_s | | Mounting to heat sink M 6 screw | 3.5 | 4.0 | 4.5 | N·m |
| d_s | Creepage distance | Terminal to terminal | 24 | - | - | mm |
| | | Terminal to base plate | 33 | - | - | |
| d_a | Clearance | Terminal to terminal | 14 | - | - | mm |
| | | Terminal to base plate | 33 | - | - | |
| m | mass | - | - | 1450 | - | g |
| e_c | Flatness of base plate | On the centerline X, Y1, Y2 (Note7) | -50 | - | +100 | μm |

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free wheeling diode (DIODE).

2. Junction temperature (T_j) should not increase beyond T_{jmax} rating.
3. Pulse width and repetition rate should be such that the device junction temperature (T_j) dose not exceed T_{jmax} rating.
4. Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
 The heat sink thermal resistance should measure just under the chips.
5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.
6. Typical value is measured by using thermally conductive grease of $\lambda=0.9 \text{ W/(m}\cdot\text{K)}$.
7. Base plate (mounting side) flatness measurement points (X, Y1 and Y2) are as follows of the following figure.



8. The company name and product names herein are the trademarks and registered trademarks of the respective companies.

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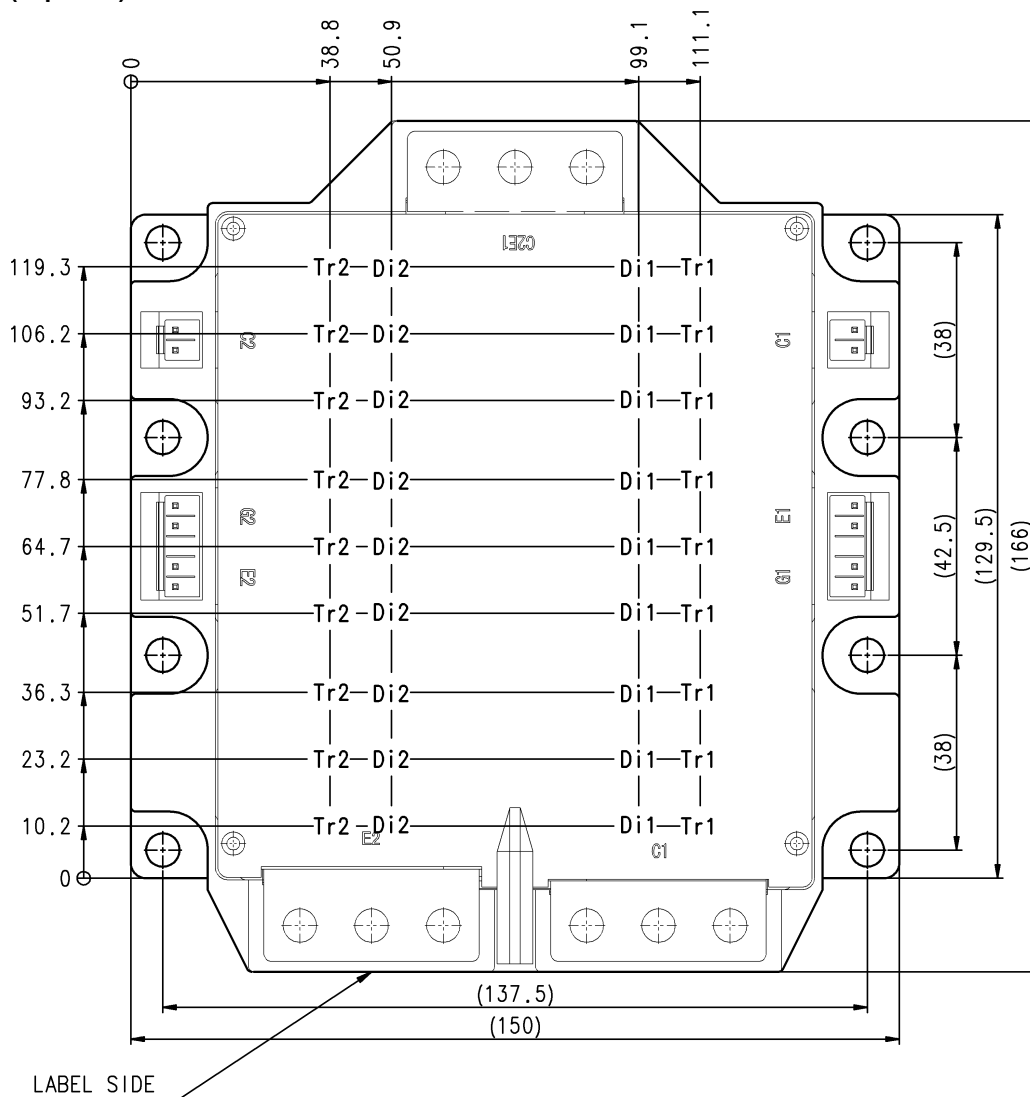
HIGH POWER SWITCHING USE
INSULATED TYPE

RECOMMENDED OPERATING CONDITIONS

| Symbol | Item | Conditions | Limits | | | Unit |
|------------|-------------------------------|------------------------------|--------|------|------|----------|
| | | | Min. | Typ. | Max. | |
| V_{CC} | (DC) Supply voltage | Applied across C1-E2 | - | 1000 | 1200 | V |
| V_{GEon} | Gate (-emitter drive) voltage | Applied across G1-Es1/G2-Es2 | 13.5 | 15.0 | 16.5 | V |
| R_G | External gate resistance | Per switch | 2.0 | - | 6.0 | Ω |

CHIP LOCATION (Top view)

Dimension in mm, tolerance: ± 1 mm

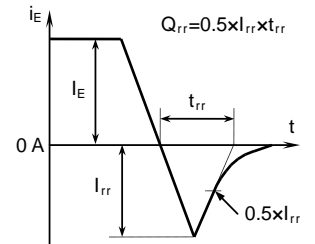
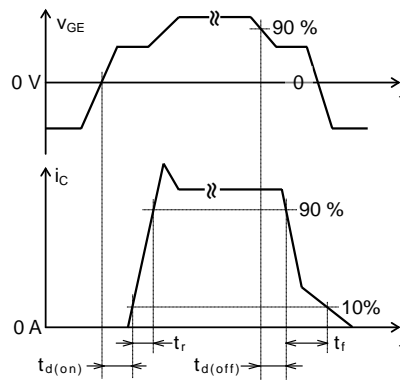
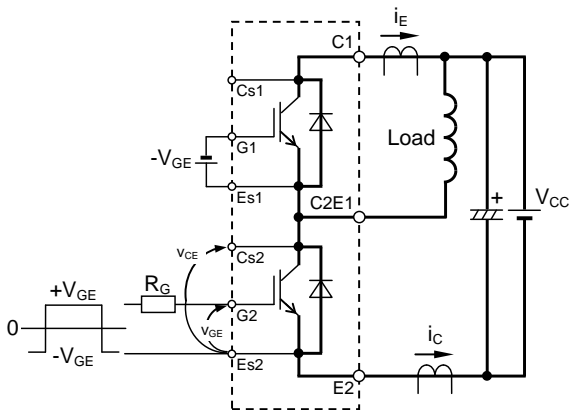


Tr1/Tr2: IGBT, Di1/Di2: DIODE

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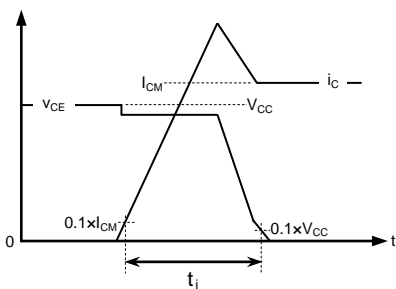
HIGH POWER SWITCHING USE
INSULATED TYPE

TEST CIRCUIT AND WAVEFORMS

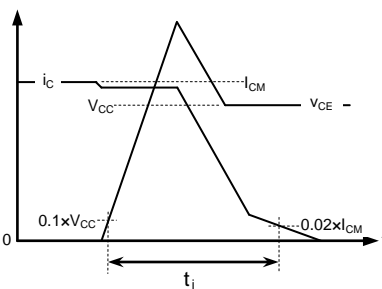


Switching characteristics test circuit and waveforms

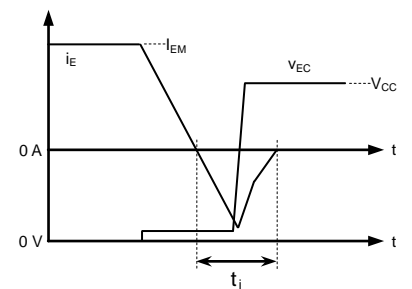
t_{rr} , Q_{rr} test waveform



IGBT Turn-on switching energy



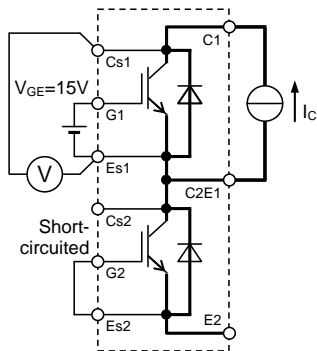
IGBT Turn-off switching energy



DIODE Reverse recovery energy

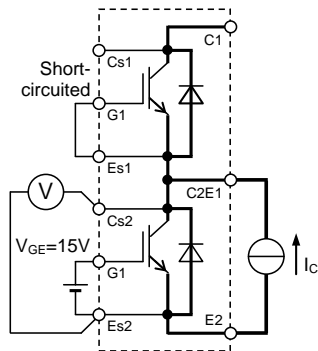
Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

TEST CIRCUIT

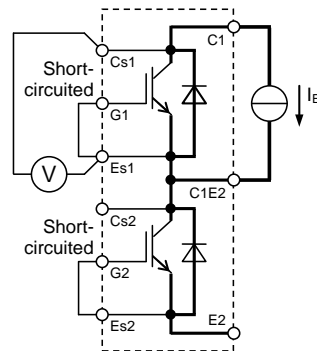


Tr1

V_{CEsat} test circuit

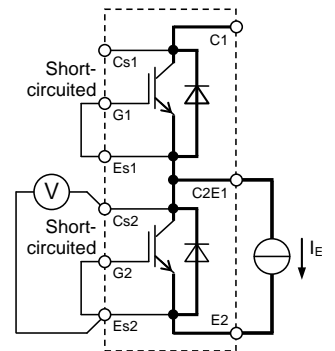


Tr2



Di1

V_{EC} test circuit



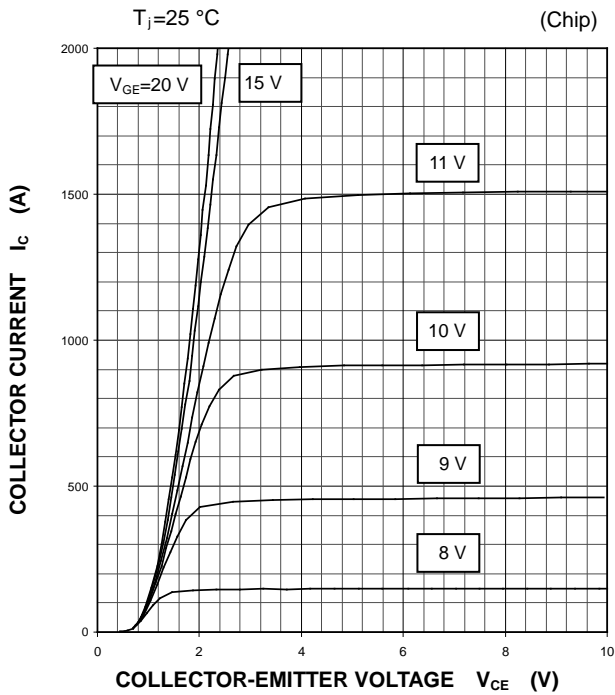
Di2

CM1000DUC-34SA

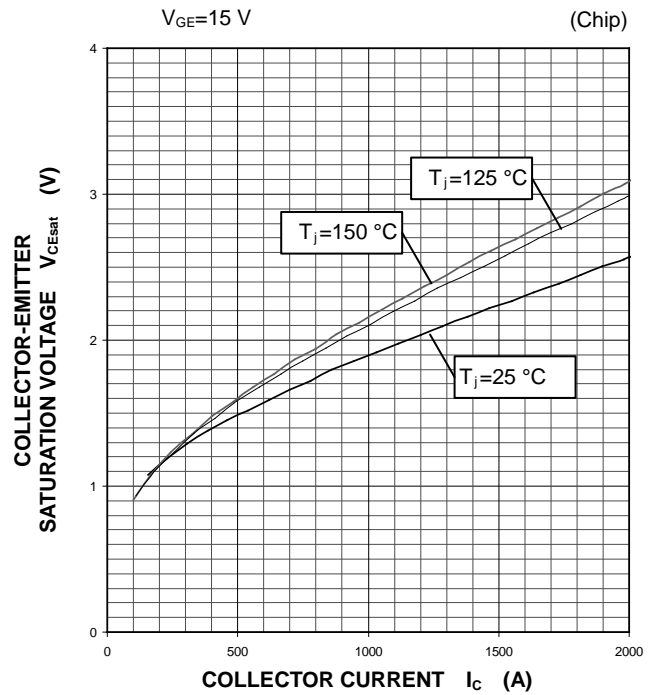
HIGH POWER SWITCHING USE
INSULATED TYPE

PERFORMANCE CURVES

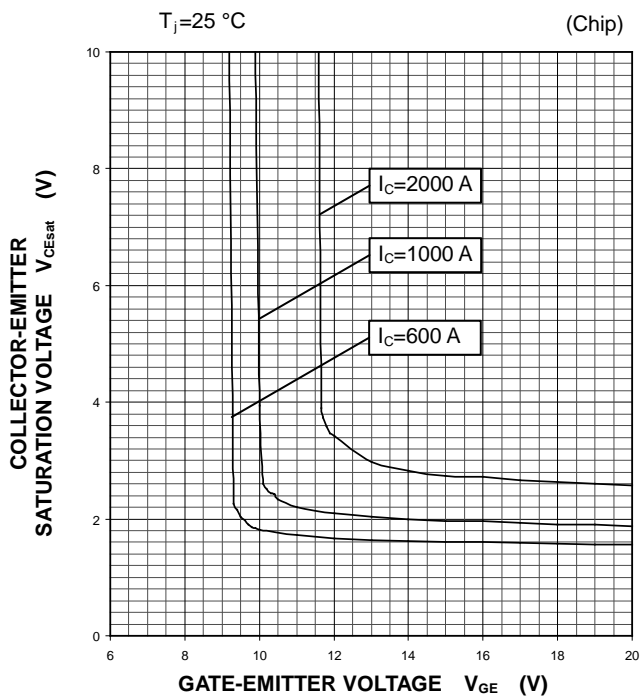
**OUTPUT CHARACTERISTICS
(TYPICAL)**



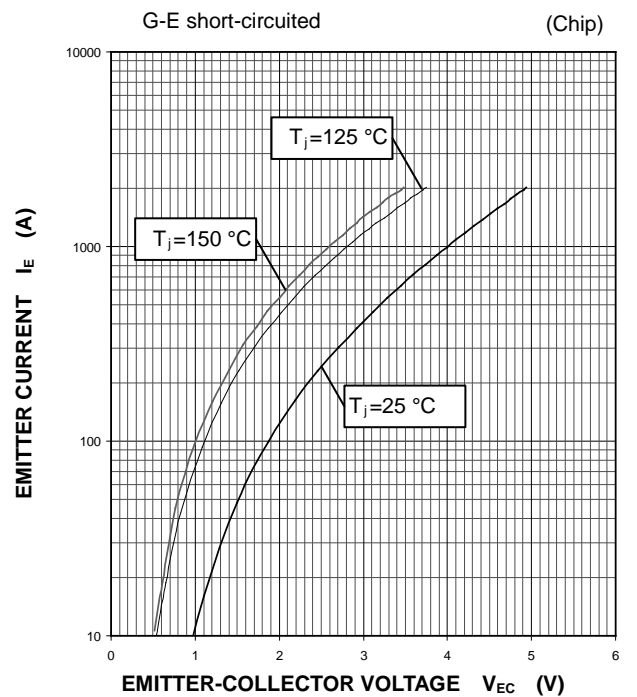
**COLLECTOR-EMITTER SATURATION
VOLTAGE CHARACTERISTICS
(TYPICAL)**



**COLLECTOR-EMITTER SATURATION
VOLTAGE CHARACTERISTICS
(TYPICAL)**



**FREE WHEELING DIODE
FORWARD CHARACTERISTICS
(TYPICAL)**



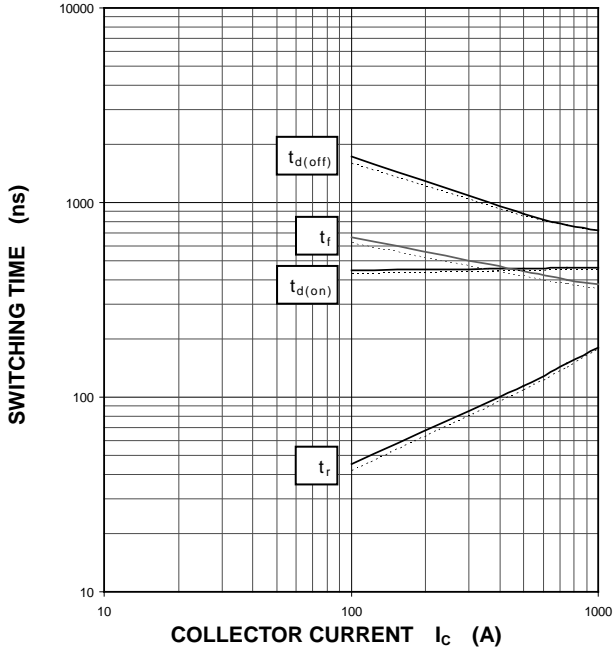
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HIGH POWER SWITCHING USE
INSULATED TYPE

PERFORMANCE CURVES

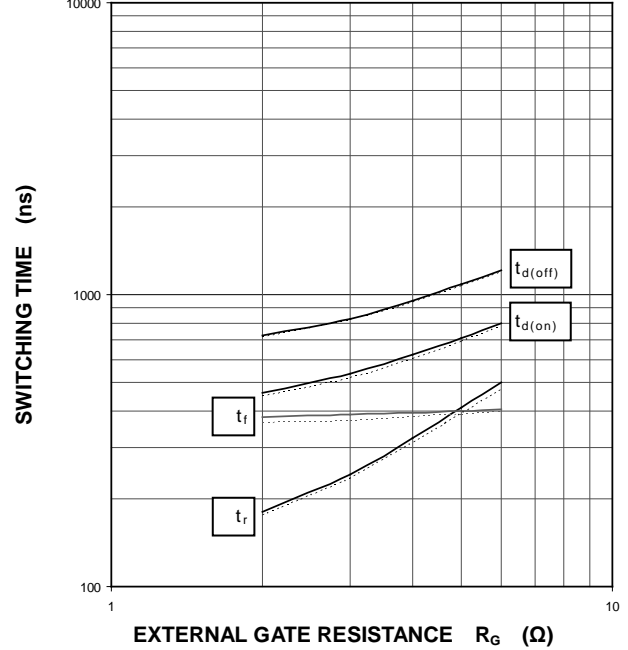
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=1000\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $R_G=2.0\ \Omega$, INDUCTIVE LOAD
 —: $T_j=150\text{ }^\circ\text{C}$, - - - - -: $T_j=125\text{ }^\circ\text{C}$



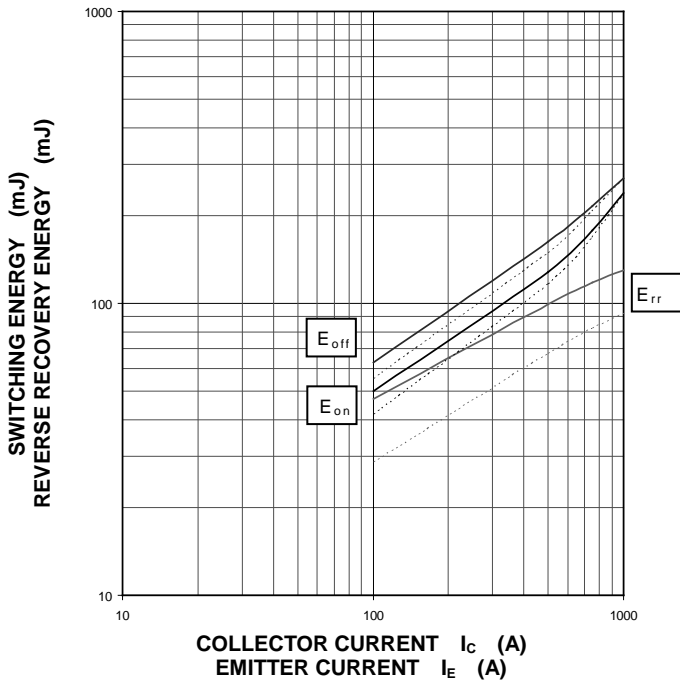
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=1000\text{ V}$, $I_C=1000\text{ A}$, $V_{GE}=\pm 15\text{ V}$, INDUCTIVE LOAD
 —: $T_j=150\text{ }^\circ\text{C}$, - - - - -: $T_j=125\text{ }^\circ\text{C}$



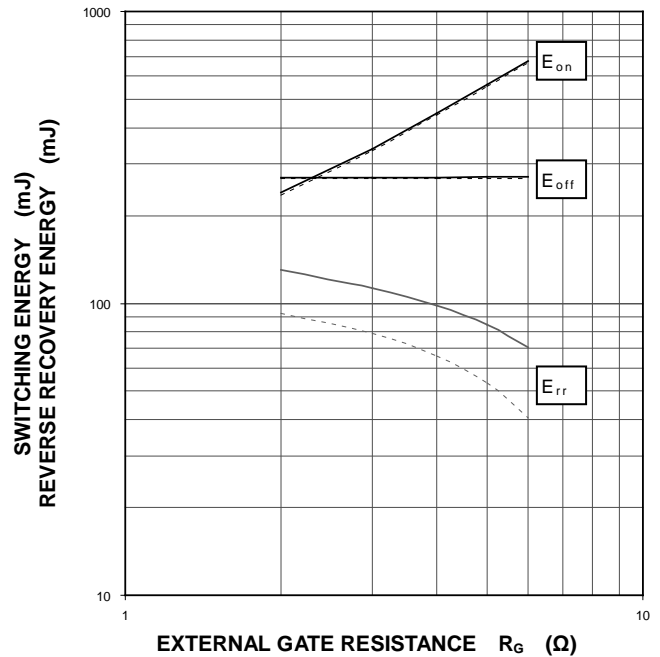
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=1000\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $R_G=2.0\ \Omega$,
INDUCTIVE LOAD, PER PULSE
 —: $T_j=150\text{ }^\circ\text{C}$, - - - - -: $T_j=125\text{ }^\circ\text{C}$



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=1000\text{ V}$, $I_C/I_E=1000\text{ A}$, $V_{GE}=\pm 15\text{ V}$,
INDUCTIVE LOAD, PER PULSE
 —: $T_j=150\text{ }^\circ\text{C}$, - - - - -: $T_j=125\text{ }^\circ\text{C}$



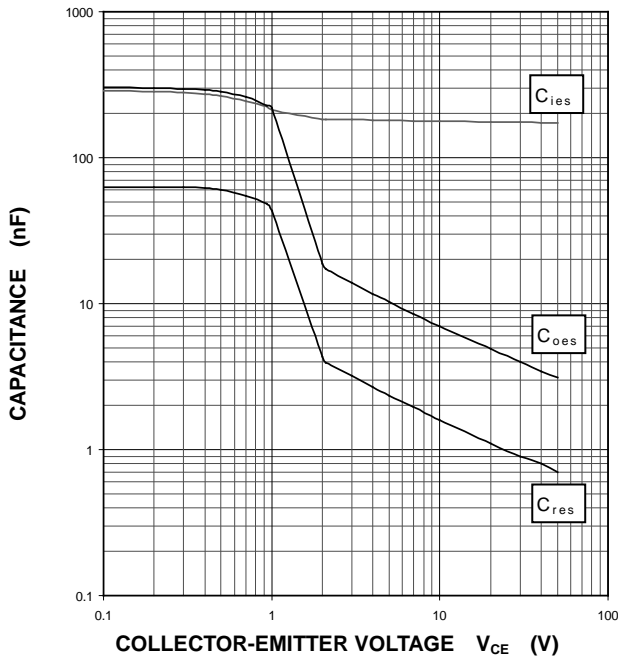
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HIGH POWER SWITCHING USE
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PERFORMANCE CURVES

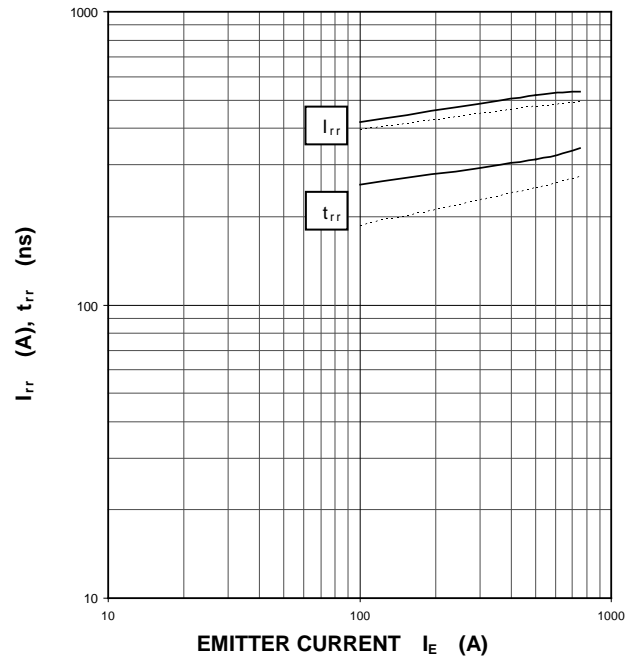
**CAPACITANCE CHARACTERISTICS
(TYPICAL)**

G-E short-circuited, $T_j=25\text{ }^\circ\text{C}$



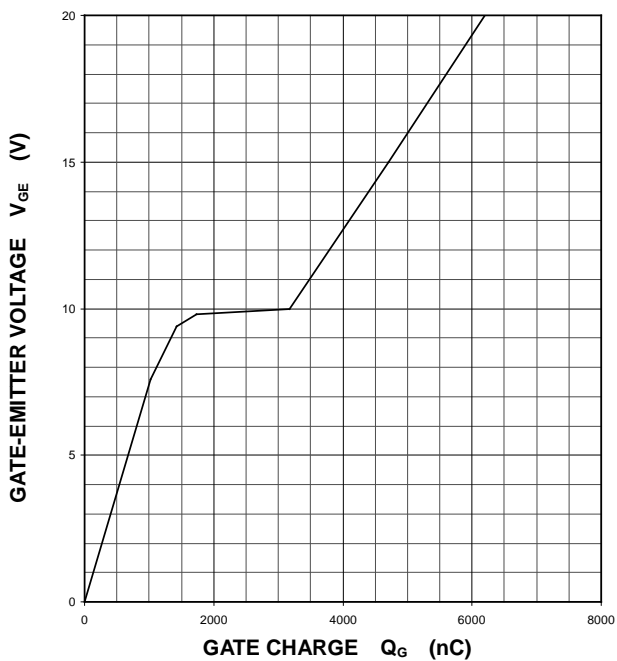
**FREE WHEELING DIODE
REVERSE RECOVERY CHARACTERISTICS
(TYPICAL)**

$V_{CC}=1000\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $R_G=2.0\ \Omega$, INDUCTIVE LOAD
—: $T_j=150\text{ }^\circ\text{C}$, - - - -: $T_j=125\text{ }^\circ\text{C}$



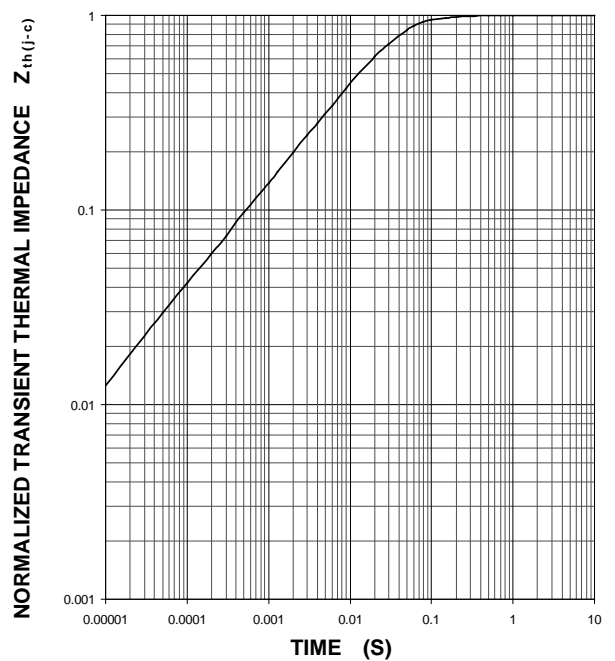
**GATE CHARGE CHARACTERISTICS
(TYPICAL)**

$V_{CC}=1000\text{ V}$, $I_C=1000\text{ A}$, $T_j=25\text{ }^\circ\text{C}$



**TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS
(MAXIMUM)**

Single pulse, $T_C=25\text{ }^\circ\text{C}$
 $R_{th(j-c)Q}=15\text{ K/kW}$, $R_{th(j-c)D}=24\text{ K/kW}$



Keep safety first in your circuit designs!

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